NEC

NPN SILICON DARLINGTON TRANSISTOR

2SD1692

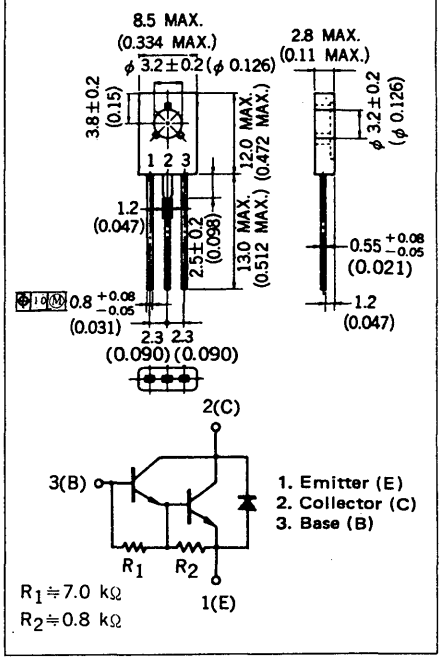
DESCRIPTION The 2SD1692 is a darlington transistor built-in dumper diode at E-C.

It is suitable for use to operate from IC without predriver, such as hammer driver.

FEATURES

- High DC Current Gain.
- Low Collector Saturation Voltage.
- Built-in a dumper diode at E-C.
- High Power Dissipation: P_T = 1.3 W (at T_a = 25 °C)

PACKAGE DIMENSIONS
in millimeters (inches)



ABSOLUTE MAXIMUM RATINGS

Maximum Temperatures

- Storage Temperature . . . . . −55 to +150 °C
- Junction Temperature . . . . . 150 °C Maximum

Maximum Power Dissipations

- Total Power Dissipation (T_a = 25 °C) . . . . . 1.3 W
- Total Power Dissipation (T_c = 25 °C) . . . . . 15 W

Maximum Voltages and Currents (T_a = 25 °C)

- V_{CBO} Collector to Base Voltage . . . . . 150 V
- V_{CEO} Collector to Emitter Voltage . . . . . 100 V
- V_{EBO} Emitter to Base Voltage . . . . . 8.0 V
- $I_{C(DC)}$ Collector Current . . . . . ±3.0 A
- $I_{C(pulse)}$* Collector Current . . . . . ±5.0 A

* PW ≦ 10 ms, Duty Cycle ≦ 50 %

ELECTRICAL CHARACTERISTICS (T_a = 25 °C)

SYMBOL	CHARACTERISTIC	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
h_{FE1}**	DC Current Gain	2000		20000	–	V_{CE} = 2.0 V, I_C = 1.5 A
h_{FE2}**	DC Current Gain	1000			–	V_{CE} = 2.0 V, I_C = 3.0 A
t_{on}	Turn On Time		0.5		μs	I_C = 1.5 A, R_L = 27 Ω I_{B1} = −I_{B2} = 1.5 mA, V_{CC} ≒ 40 V See Test Circuit.
t_{stg}	Storage Time		2.0		μs	
t_f	Fall Time		1.0		μs	
I_{CBO}	Collector Cutoff Current			10	μA	V_{CB} = 100 V, I_E = 0
I_{EBO}	Emitter Cutoff Current			1.0	mA	V_{EB} = 5.0 V, I_C = 0
$V_{CE(sat)}$**	Collector Saturation Voltage		0.9	1.2	V	I_C = 1.5 A, I_B = 1.5 mA
$V_{BE(sat)}$**	Base Saturation Voltage		1.5	2.0	V	I_C = 1.5 A, I_B = 1.5 mA

** Pulsed / PW ≦ 350 μs, Duty Cycle ≦ 2 %

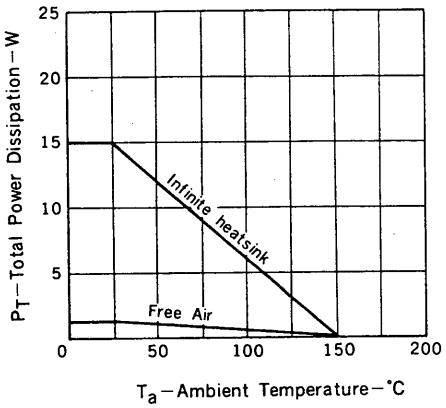
Classification of h_{FE1}

Rank	M	L	K
Range	2000 to 5000	4000 to 10000	8000 to 20000

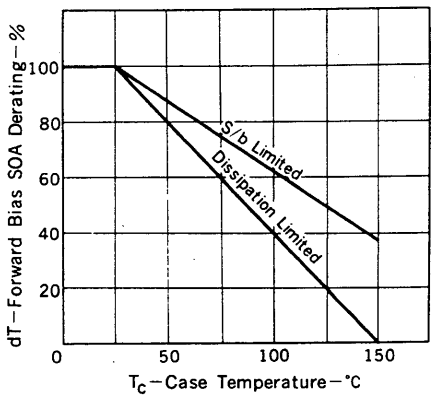
Test Conditions: V_{CE} = 2.0 V, I_C = 1.5 A

TYPICAL CHARACTERISTICS (T_a = 25 °C)

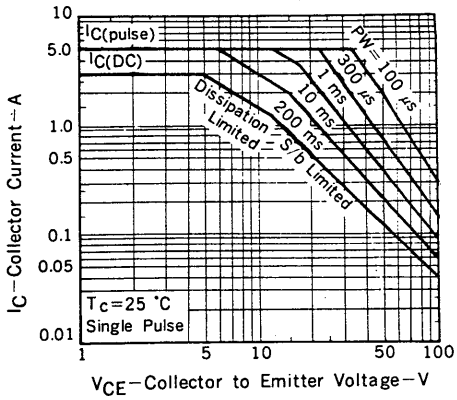
TOTAL POWER DISSIPATION vs. AMBIENT TEMPERATURE



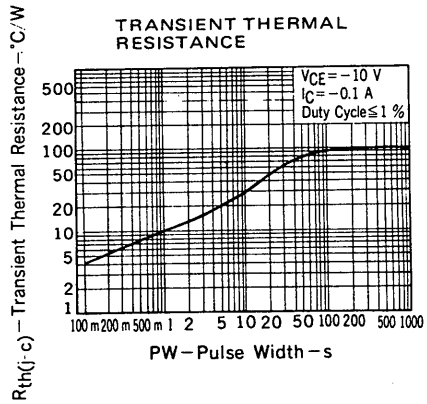
DERATING CURVE OF SAFE OPERATING AREA



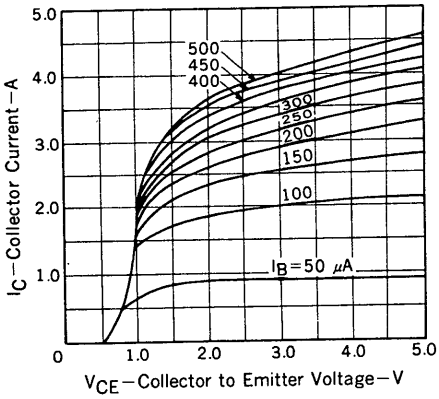
FORWARD BIAS SAFE OPERATING AREA



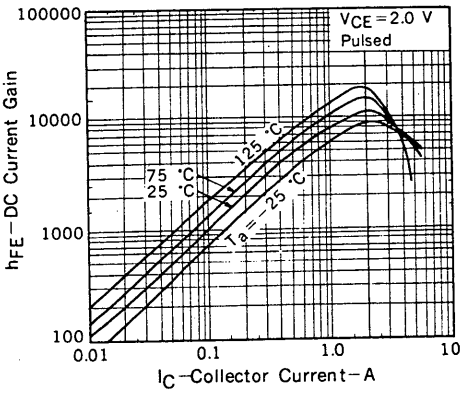
TRANSIENT THERMAL RESISTANCE



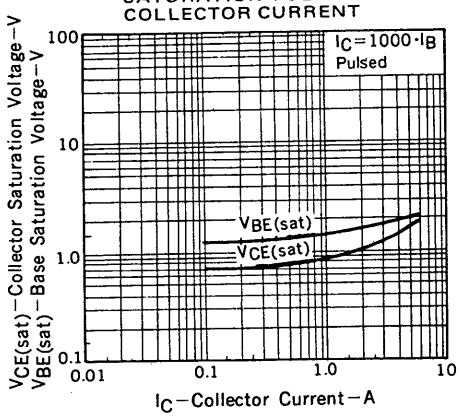
COLLECTOR CURRENT vs. COLLECTOR TO EMITTER VOLTAGE



DC CURRENT GAIN vs. COLLECTOR CURRENT



BASE AND COLLECTOR SATURATION VOLTAGE vs. COLLECTOR CURRENT



SWITCHING TIME (t_{on}, t_{stg}, t_f) TEST CIRCUIT